查询SN74LVC827供应商	SN74LVC827 10-BIT BUFFER/DRIVER WITH 3-STATE OUTPUTS SCAS306B – MARCH 1993 – REVISED JULY 1995
 EPIC ™ (Enhanced-Performance Implanted	DB, DW, OR PW PACKAGE
CMOS) Submicron Process	(TOP VIEW)
 Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, T_A = 25°C 	$ \overline{OE1} \begin{bmatrix} 1 & 24 \\ 2 & 23 \end{bmatrix} V_{CC} $
 Typical V_{OHV} (Output V_{OH} Undershoot) 2 V at V_{CC} = 3.3 V, T_A = 25°C 	A2 [3 22] Y2 A3 [4 21] Y3
 Latch-Up Performance Exceeds 250 mA	A4 [5 20] Y4
Per JEDEC Standard JESD-17	A5 [6 19] Y5
 Package Options Include Plastic	A6 [7 18] Y6
Small-Outline (DW), Shrink Small-Outline	A7 [8 17] Y7
(DB), and Thin Shrink Small-Outline (PW)	A8 [] 9 16 [] Y8
Packages	A9 [] 10 15 [] Y9
description	A10 [11 14] Y10 GND [12 13] OE2

This 10-bit buffer/bus driver is designed for 2.7-V to 3.6-V V_{CC} operation.

The SN74LVC827 provides a high-performance bus interface for wide data paths or buses carrying parity.

The 3-state control gate is a 2-input AND gate with active-low inputs so that if either output-enable (OE1 or OE2) input is high, all ten outputs are in the high-impedance state. The SN74LVC827 provides true data at its outputs.

To ensure the high-impedance state during power up or power down, OE should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74LVC827 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE								
	INPUTS	OUTPUT						
OE1	OE2	Α	Y					
L	L	L	L					
L	L	Н	Н					
Н	Х	Х	Z					
Х	Н	Х	Z					

EUNCTION TABLE



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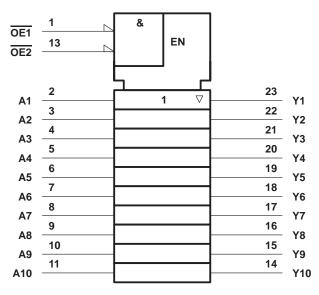


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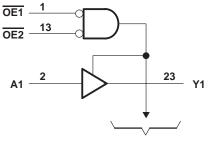
SN74LVC827 10-BIT BUFFER/DRIVER WITH 3-STATE OUTPUTS

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logic symbol[†]



logic diagram (positive logic)



To Nine Other Channels

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC}	
Input voltage range, V _I (see Note 1)	−0.5 V to 6.5 V
Output voltage range, V _O (see Notes 1 and 2)	$\dots \dots \dots -0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I _{IK} (V _I < 0)	– 50 mA
Output clamp current, I_{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 3): DB pace	kage 0.65 W
DW pac	ckage 1.7 W
PW pac	ckage 0.7 W
Storage temperature range, T _{stg}	•

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. This value is limited to 4.6 V maximum.

3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the Package Thermal Considerations application note in the 1994 ABT Advanced BiCMOS Technology Data Book, literature number SCBD002B.



recommended operating conditions (see Note 4)

		MIN	MAX	UNIT
Vcc	Supply voltage	2.7	3.6	V
VIH	High-level input voltage $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		V
VIL	Low-level input voltage $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8	V
VI	Input voltage	0	5.5	V
VO	Output voltage	0	VCC	V
IOH High-level of	High-level output current		-12	mA
	V _{CC} = 3 V		-24	ША
IOL	Low-level output current		12	mA
	V _{CC} = 3 V		24	ША
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	-40	85	°C

NOTE 4: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDI	TIONS	Vcc [†]	MIN	TYP‡	MAX	UNIT	
	I _{OH} = -100 μA		MIN to MAX	V _{CC} -0.	2			
Vou			2.7 V	2.2			М	
VOH	OH = -12 IIIA	I _{OH} = – 12 mA		2.4			V	
	I _{OH} = - 24 mA		3 V	2				
	I _{OL} = 100 μA		MIN to MAX			0.2		
V _{OL}	I _{OL} = 12 mA		2.7 V			0.4	V	
	I _{OL} = 24 mA		3 V			0.55		
lj	$V_{I} = 5.5 V \text{ or GND}$		3.6 V			±5	μA	
I _{OZ}	$V_{O} = V_{CC}$ or GND		3.6 V			±10	μΑ	
Icc	$V_{I} = V_{CC} \text{ or } GND,$ IO =	= 0	3.6 V			20	μA	
ΔI_{CC}	One input at V _{CC} – 0.6 V, Oth	er inputs at V _{CC} or GND	3 V to 3.6 V			500	μA	
Ci	$V_I = V_{CC}$ or GND		3.3 V		9		pF	
Co	$V_{O} = V_{CC}$ or GND		3.3 V		10		pF	

[†] For conditions shown as MIN or MAX, use the appropriate values under recommended operating conditions.

[‡] All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

switching characteristics over recommended operating free-air temperature range, CL = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	TER FROM (INPUT)	TO (OUTPUT)	V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V		UNIT
			MIN	MAX	MIN	MAX	
^t pd	A	Y	1.5	7		8	ns
ten	OE	Y	1.5	9		11	ns
^t dis	OE	Y	1.5	8		9	ns

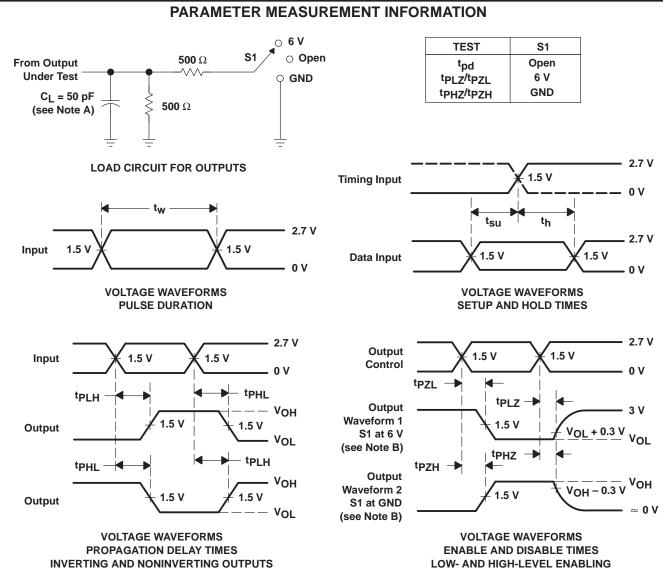


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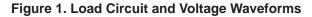
operating characteristics, $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}C$

PARAMETER		TEST CONDITIONS	TYP	UNIT	
C _{pd} Power dissipation of	Power dissipation consolitance per huffer/driver	Outputs enabled	C ₁ = 50 pF. f = 10 MHz	25	рF
	Power dissipation capacitance per buffer/driver	Outputs disabled	$C_{L} = 50 \text{ pF}, \text{ f} = 10 \text{ MHz}$	2.5	



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_Q = 50 Ω, t_f ≤ 2.5 ns. t_f ≤ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. tpLH and tpHL are the same as t_{pd} .





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